

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination FURUKAWA ET AL.	
		Examiner Stephen D'Adamo	Art Unit 3636	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,682,494	01-2004	Sleichter et al.	601/57
	B	US-6,206,475	03-2001	Tai, Martin	297/452.41
	C	US-6,158,808	12-2000	Margolis et al.	297/330
	D	US-6,135,551	10-2000	Linder, Steven G.	297/217.4
	E	US-6,028,520	02-2000	Maehre, Bob	340/573.1
	F	US-5,713,832	02-1998	Jain, Anand Sagar	601/49
	G	US-5,713,633	02-1998	Lu, Kuo-Ching	297/364
	H	US-5,636,852	06-1997	Sistrunk et al.	280/30
	I	US-5,624,156	04-1997	Leal et al.	297/217.4
	J	US-5,610,674	03-1997	Martin, David A.	352/85
	K	US-4,310,307	01-1982	Bellisario, Nolan	433/33
	L	US-1,704,415	03-1929	Wenegrat, B.	297/217.6
	M	US-2002/0165583	11-2002	Tepper et al.	607/2

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 9400206 A1	01-1994	World Intellect	TAKEMOTO et al.	A63F 07/02
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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